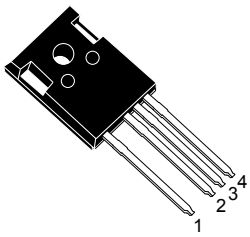
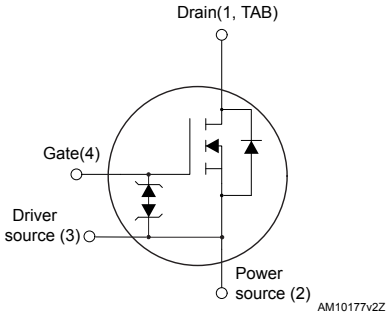
STW68N65DM6-4AG

Datasheet

Automotive-grade N-channel 650 V, 33 mΩ typ., 72 A MDmesh DM6 Power MOSFET in a TO247-4 package



TO247-4



STPOWER

Product status link
STW68N65DM6-4AG

Product summary	
Order code	STW68N65DM6-4AG
Marking	68N65DM6AG
Package	TO247-4
Packing	Tube

Features

Order code	V_{DS}	$R_{DS(on)}$ max.	I_D
STW68N65DM6-4AG	650 V	39 mΩ	72 A

- AEC-Q101 qualified
- Fast-recovery body diode
- Lower $R_{DS(on)}$ per area vs previous generation
- Low gate charge, input capacitance and resistance
- 100% avalanche tested
- Extremely high dv/dt ruggedness
- Excellent switching performance thanks to the extra driving source pin
- Zener-protected

Applications

- Switching applications

Description

This high-voltage N-channel Power MOSFET is part of the MDmesh DM6 fast-recovery diode series. Compared with the previous MDmesh fast generation, DM6 combines very low recovery charge (Q_{rr}), recovery time (t_{rr}) and excellent improvement in $R_{DS(on)}$ per area with one of the most effective switching behaviors available in the market for the most demanding high-efficiency bridge topologies and ZVS phase-shift converters.

1 Electrical ratings

Table 1. Absolute maximum ratings

Symbol	Parameter	Value	Unit
V_{GS}	Gate-source voltage	±25	V
I_D	Drain current (continuous) at T_C = 25 °C	72	A
	Drain current (continuous) at T_C = 100 °C	46	
I_{DM} (1)	Drain current (pulsed)	280	A
P_{TOT}	Total power dissipation at T_C = 25 °C	480	W
dv/dt (2)	Peak diode recovery voltage slope	100	V/ns
di/dt (2)	Peak diode recovery current slope	1000	A/µs
dv/dt (3)	MOSFET dv/dt ruggedness	100	V/ns
T_{stg}	Storage temperature range	-55 to 150	°C
T_J	Operating junction temperature range		°C

1. *Pulse width limited by safe operating area.*
2. *I_{SD} ≤ 72 A, V_{DS} (peak) < $V_{(BR)DSS}$, V_{DD} = 400 V.*
3. *V_{DD} ≤ 520 V.*

Table 2. Thermal data

Symbol	Parameter	Value	Unit
R_{thJC}	Thermal resistance, junction-to-case	0.26	°C/W
R_{thJA}	Thermal resistance, junction-to-ambient	50	°C/W

Table 3. Avalanche characteristics

Symbol	Parameter	Value	Unit
I_{AR}	Avalanche current, repetitive or not repetitive (pulse width limited by T_J max.)	9	A
E_{AS}	Single pulse avalanche energy (starting T_J = 25 °C, I_D = I_{AR})	1.9	J

2 Electrical characteristics

T_C = 25 °C unless otherwise specified

Table 4. On/off states

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$V_{(BR)DSS}$	Drain-source breakdown voltage	V_{GS} = 0 V, I_D = 1 mA	650			V
I_{DSS}	Zero gate voltage drain current	V_{GS} = 0 V, V_{DS} = 650 V			10	µA
		V_{GS} = 0 V, V_{DS} = 650 V, T_C = 125 °C(1)			300	
I_{GSS}	Gate-body leakage current	V_{DS} = 0 V, V_{GS} = ±25 V			±5	µA
$V_{GS(th)}$	Gate threshold voltage	V_{DS} = V_{GS}, I_D = 250 µA	3.25	4	4.75	V
$R_{DS(on)}$	Static drain-source on resistance	V_{GS} = 10 V, I_D = 36 A		33	39	mΩ

1. *Specified by design, not tested in production.*

Table 5. Dynamic characteristics

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
C_{iss}	Input capacitance	V_{DS} = 100 V, f = 1 MHz, V_{GS} = 0 V	-	5900	-	pF
C_{oss}	Output capacitance		-	260	-	
C_{rss}	Reverse transfer capacitance		-	2.6	-	
$C_{oss\ eq.}$(1)	Equivalent output capacitance	V_{DS} = 0 to 520 V, V_{GS} = 0 V	-	867	-	
R_g	Intrinsic gate resistance	f = 1 MHz, I_D = 0 A	-	1.4	-	Ω
Q_g	Total gate charge	V_{DD} = 520 V, I_D = 72 A, V_{GS} = 0 to 10 V (see Figure 14. Test circuit for gate charge behavior)	-	118	-	nC
Q_{gs}	Gate-source charge		-	37	-	
Q_{gd}	Gate-drain charge		-	48	-	

1. *$C_{oss\ eq}$ is defined as a constant equivalent capacitance giving the same charging time as C_{oss} when V_{DS} increases from 0 to 80% V_{DSS}.*

Table 6. Switching times

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$t_{d(on)}$	Turn-on delay time	V_{DD} = 325 V, I_D = 36 A, R_G = 4.7 Ω , V_{GS} = 10 V (see Figure 13. Switching times test circuit for resistive load and Figure 18. Switching time waveform)	-	34	-	ns
t_r	Rise time		-	16	-	ns
$t_{d(off)}$	Turn-off delay time		-	92	-	ns
t_f	Fall time		-	10	-	ns

Table 7. Source-drain diode

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
I_{SD}	Source-drain current		-		72	A
I_{SDM}(1)	Source-drain current (pulsed)		-		280	A
V_{SD}(2)	Forward on voltage	V_{GS} = 0 V, I_{SD} = 72 A	-		1.6	V
t_{rr}	Reverse recovery time	I_{SD} = 72 A, di/dt = 100 A/µs, V_{DD} = 60 V (see Figure 15. Test circuit for inductive load switching and diode recovery times)	-	142	-	ns
Q_{rr}	Reverse recovery charge		-	0.9	-	µC
I_{RRM}	Reverse recovery current		-	10.6	-	A
t_{rr}	Reverse recovery time	I_{SD} = 72 A, di/dt = 100 A/µs, V_{DD} = 60 V, T_J = 150 °C (see Figure 15. Test circuit for inductive load switching and diode recovery times)	-	310	-	ns
Q_{rr}	Reverse recovery charge		-	4.5	-	µC
I_{RRM}	Reverse recovery current		-	26	-	A

1. *Pulse width is limited by safe operating area.*
2. *Pulsed: pulse duration = 300 µs, duty cycle 1.5%.*

2.1 Electrical characteristics (curves)

Figure 1. Safe operating area

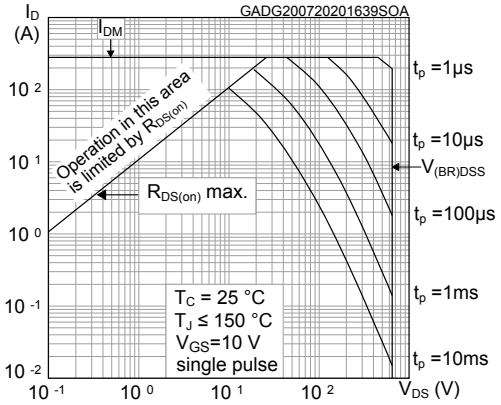


Figure 2. Maximum transient thermal impedance

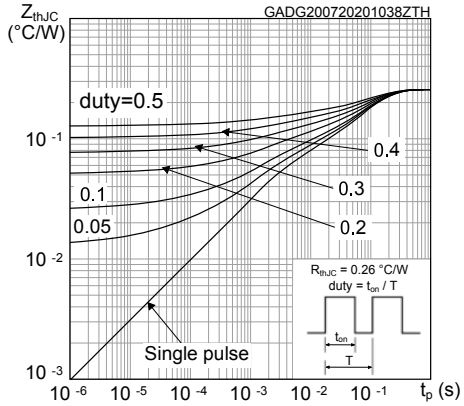


Figure 3. Typical output characteristics

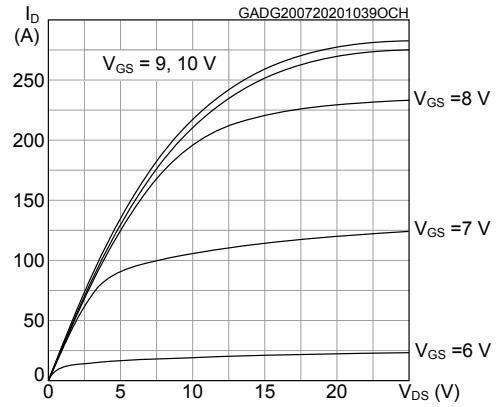


Figure 4. Typical transfer characteristics

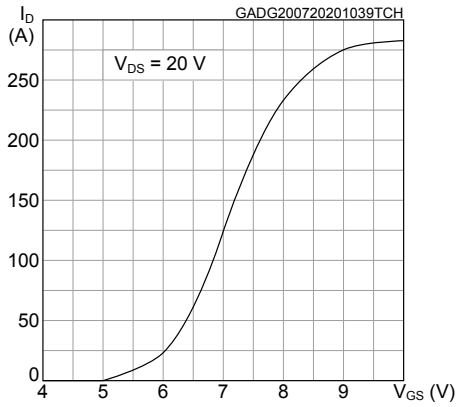


Figure 5. Typical gate charge characteristics

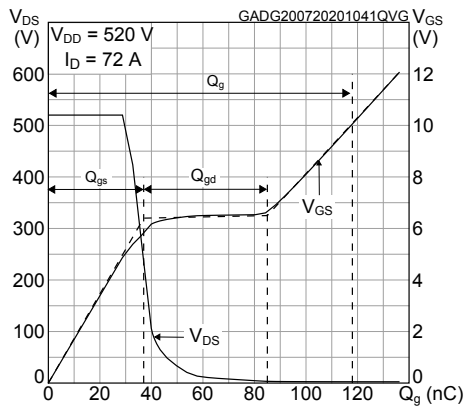


Figure 6. Typical drain-source on-resistance

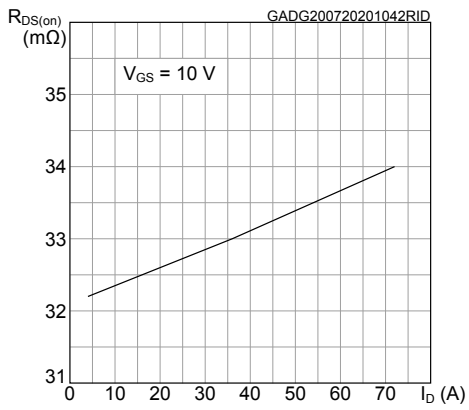


Figure 7. Typical capacitance characteristics

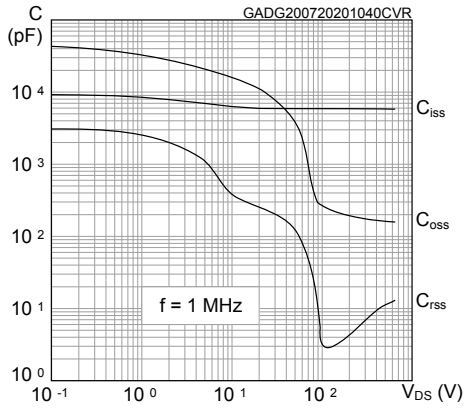


Figure 8. Typical output capacitance stored energy

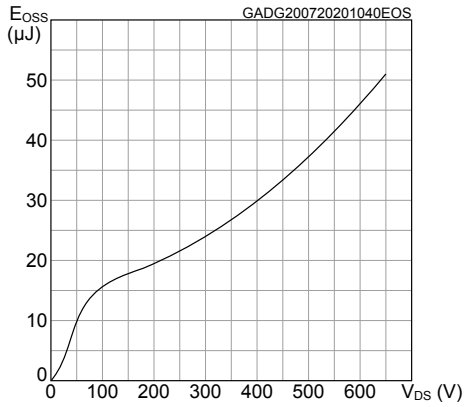


Figure 9. Normalized gate threshold vs temperature

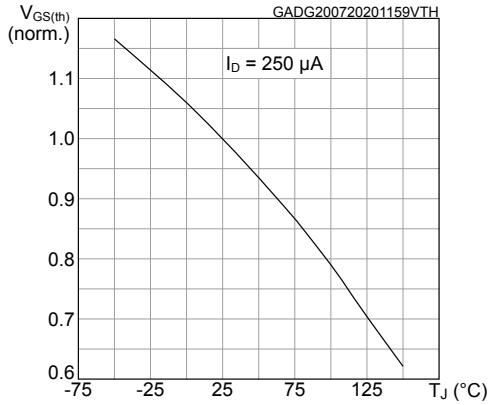


Figure 10. Normalized on-resistance vs temperature

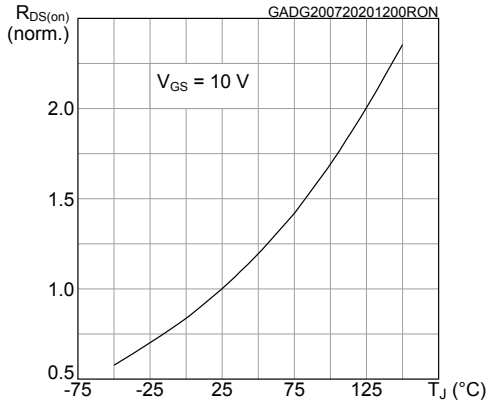


Figure 11. Normalized breakdown voltage vs temperature

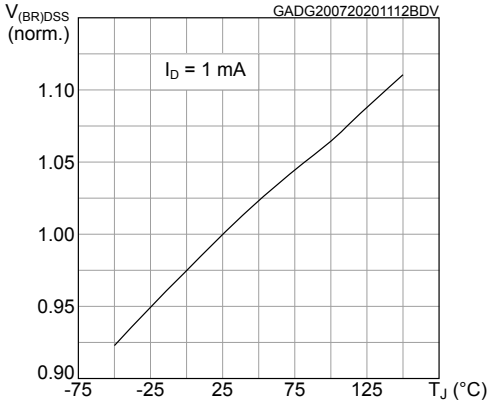
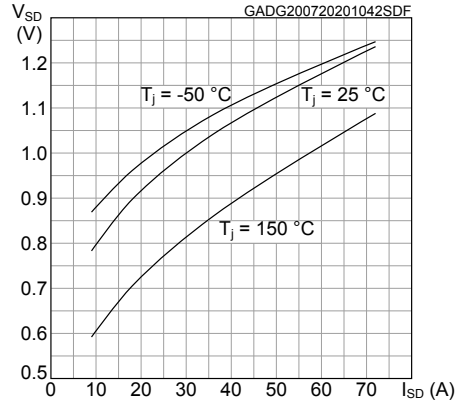


Figure 12. Typical reverse diode forward characteristics



3 Test circuits

Figure 13. Switching times test circuit for resistive load

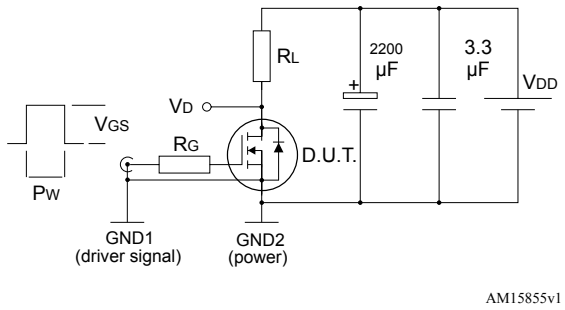


Figure 14. Test circuit for gate charge behavior

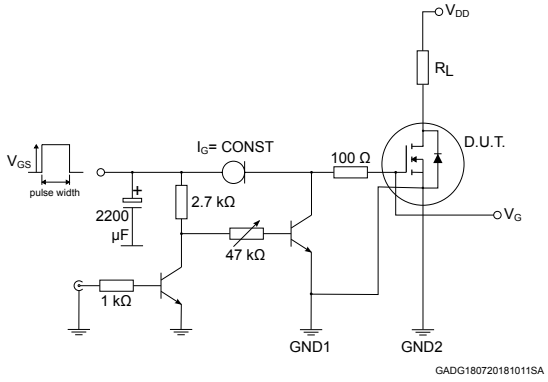


Figure 15. Test circuit for inductive load switching and diode recovery times

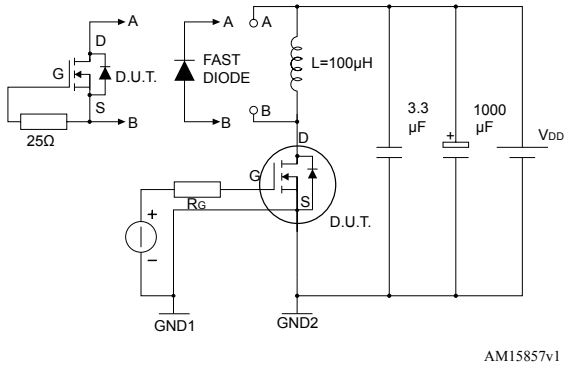


Figure 16. Unclamped inductive load test circuit

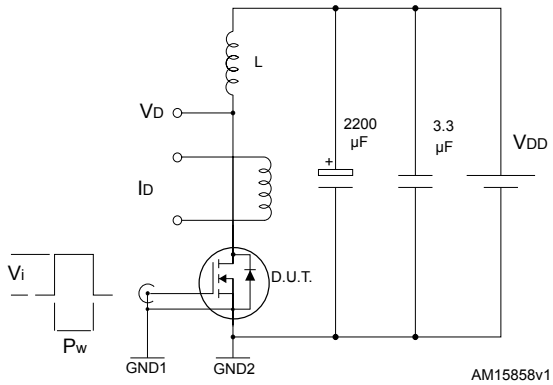


Figure 17. Unclamped inductive waveform

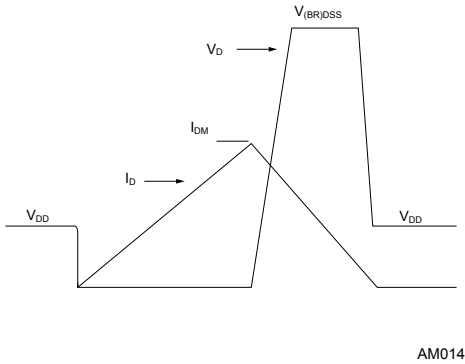
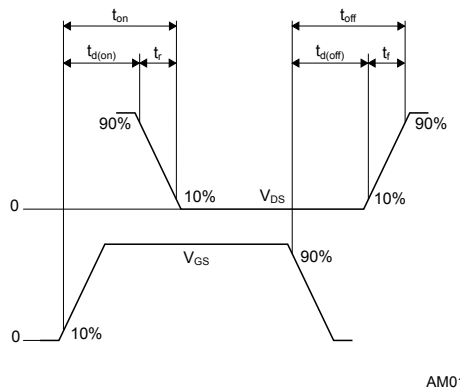


Figure 18. Switching time waveform



4 Package information

To meet environmental requirements, ST offers these devices in different grades of ECOPACK packages, depending on their level of environmental compliance. ECOPACK specifications, grade definitions, and product status are available at: www.st.com. ECOPACK is an ST trademark.

4.1 TO247-4 package information

Figure 19. TO247-4 package outline

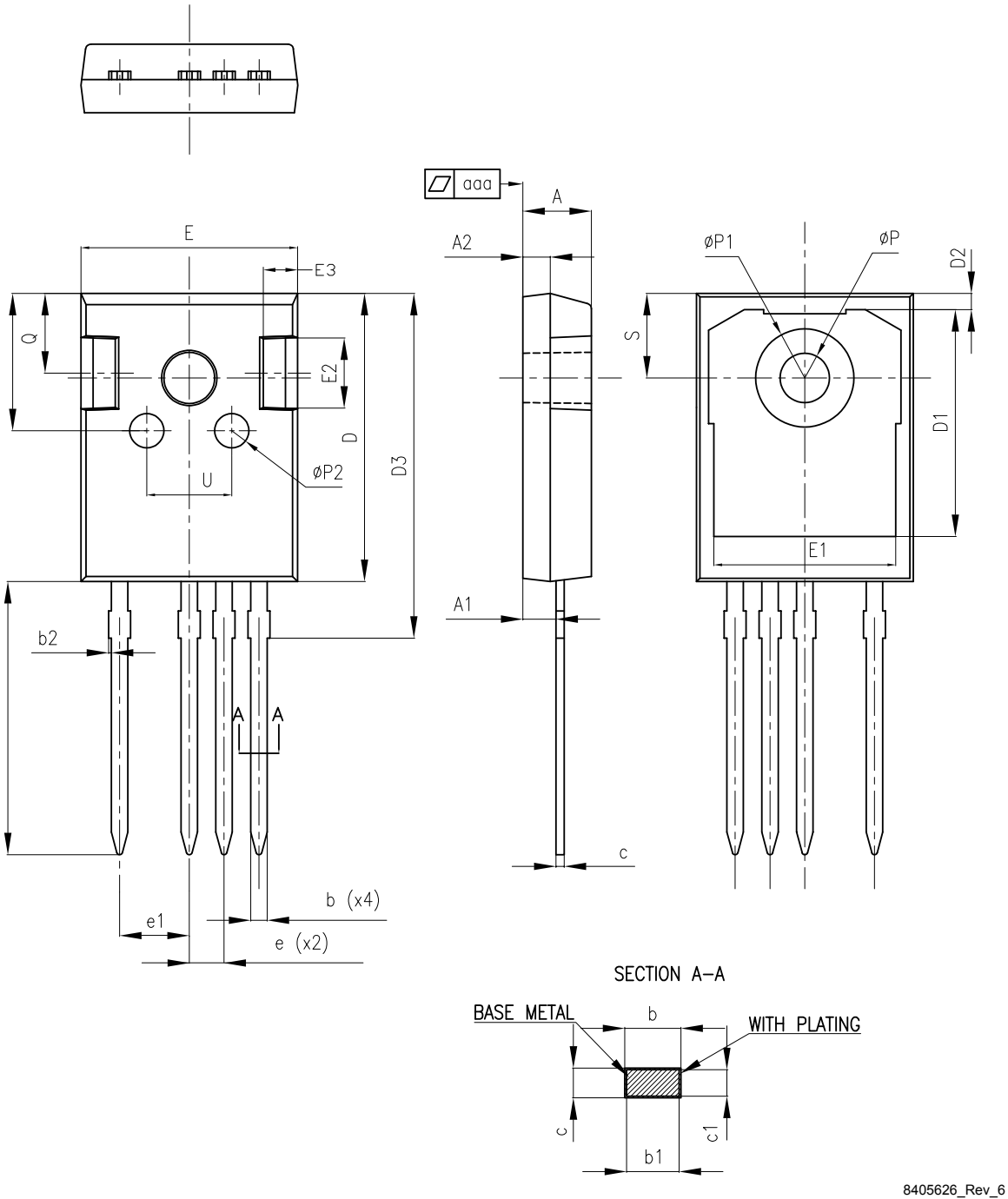


Table 8. **TO247-4 mechanical data**

Dim.	mm		
	Min.	Typ.	Max.
A	4.90	5.00	5.10
A1	2.31	2.41	2.51
A2	1.90	2.00	2.10
b	1.16		1.29
b1	1.15	1.20	1.25
b2	0.00		0.20
c	0.59		0.66
c1	0.58	0.60	0.62
D	20.90	21.00	21.10
D1	16.25	16.55	16.85
D2	1.05	1.20	1.35
D3	24.97	25.12	25.27
E	15.70	15.80	15.90
E1	13.10	13.30	13.50
E2	4.90	5.00	5.10
E3	2.40	2.50	2.60
e	2.44	2.54	2.64
e1	4.98	5.08	5.18
L	19.80	19.92	20.10
P	3.50	3.60	3.70
P1			7.40
P2	2.40	2.50	2.60
Q	5.60		6.00
S		6.15	
T	9.80		10.20
U	6.00		6.40
aaa		0.04	0.10

Revision history

Table 9. **Document revision history**

Date	Version	Changes
21-Apr-2020	1	First release.
20-Jul-2020	2	Modified *Table 1. Absolute maximum ratings*, *Table 3. Avalanche characteristics*, *Table 4. On/off states*, Table 5. *Dynamic characteristics*, *Table 6. Switching times* and *Table 7. Source-drain diode.* Added *Section 2.1 Electrical characteristics (curves).* Minor text changes.
02-Feb-2026	3	Updated Section 4.1: TO247-4 package information. Minor text changes.

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